



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BVsss	Rss(on) Typ	Is Max TA = +25°C
24V	$7.4 \text{m}\Omega$ @ $V_{GS} = 3.8 \text{V}$	13.0A

Description

This new generation MOSFET is designed to minimize the on-state resistance (Rss(ON)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Battery Management
- Load Switch
- Battery Protection

Features

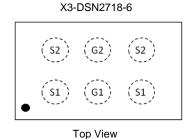
- CSP with Footprint 2.70mm x 1.81mm
- Height = 0.21mm for Low Profile
- · ESD Protection of Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

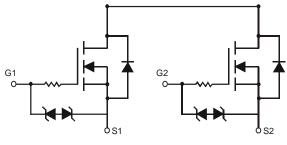
 https://www.diodes.com/quality/product-definitions/

Mechanical Data

- Case: X3-DSN2718-6
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu or NiAu. Solderable per MIL-STD-202, Method 208
- Weight: 0.0026 grams (Approximate)







Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMN2012UCA6-7	X3-DSN2718-6	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information

M3 YM

 $\begin{array}{l} M3 = Product\ Type\ Marking\ Code \\ YM = Date\ Code\ Marking \\ Y\ or\ \overline{Y} = Year\ (ex:\ G = 2019) \\ M\ or\ \overline{M} = Month\ (ex:\ 9 = September) \end{array}$

Date Code Key

Year	2018	2019	20	020	2021	2022	2	2023	2024	202	25	2026
Code	F	G		Н		J		K	L	N	1	N
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
141011111	Juli	1 65	IVICII	Aþi	iviay	Juli	Jui	Aug	Sep	OCI	1404	Dec



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characterist	Symbol	Value	Unit		
Source-Source Voltage	V _{SSS}	24	V		
Gate-Source Voltage	Vgss	±12	V		
Continuous Course Current (Note E) V 4 EV	Steady State	T _A = +25°C	I-	13.0	^
Continuous Source Current (Note 5) V _{GS} = 4.5V		T _A = +70°C	Is	10.4	Α
Continuous Course Courset (Nata 5) \	Ctandy Ctata	T _A = +25°C	1	10.8	^
Continuous Source Current (Note 5) V _{GS} = 2.5V	Steady State	T _A = +70°C	Is	8.6	А
Pulsed Source Current (Note 6)	I _{SM}	60	Α		

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 7)	P _D	0.82	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 7)	Reja	151.9	°C/W
Power Dissipation (Note 5)	P _D	2.3	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	Reja	55.0	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

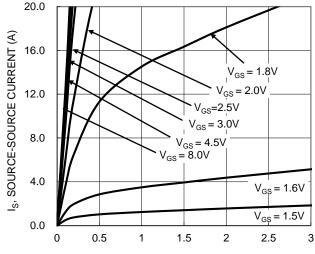
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)				,			
Source-Source Breakdown Voltage	BVsss	24	_	_	V	$V_{GS} = 0V$, $I_{S} = 1mA$	
Zero Gate Voltage Source Current T _J = +25°C	I _{SSS}	_	_	1	μΑ	$V_{SS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	lgss	_	_	±10	μΑ	$V_{GS} = \pm 12V$, $V_{SS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	Vgs(th)	0.5	0.9	1.3	V	$V_{SS} = 10V$, $I_{S} = 1mA$	
		_	7.0	9.0		V _G S = 4.5V, I _S = 5A	
		_	7.3	9.5		$V_{GS} = 4.0V, I_{S} = 5A$	
Static Source-Source On-Resistance	Rss(on)	_	7.4	10.1	mΩ	V _G S = 3.8V, I _S = 5A	
		_	7.9	10.3		V _{GS} = 3.1V, I _S = 5A	
		_	9.1	13.0		$V_{GS} = 2.5V, I_{S} = 5A$	
Diode Forward Voltage	Vss	_	0.7	_	V	V _G S = 0V, I _S = 10A	
DYNAMIC CHARACTERISTICS (Note 9)	•	•			•	•	
Input Capacitance	Ciss	_	2417	_		101/11/101/	
Output Capacitance	Coss	_	270	_	pF	$V_{SS} = 10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	_	102	_		1 = 1.0IVII 12	
Total Gate Charge	Qg	_	26.0	_			
Gate-Source Charge	Qgs	_	5.2	_	nC	$V_{SS} = 19.2V, V_{GS} = 4.0V,$	
Gate-Drain Charge	Qgd	_	9.5	_	nC	Is = 3A	
Gate Charge at VTH	Q _g (TH)	_	4.5	_			
Turn-On Delay Time	tD(ON)	_	543	_			
Turn-On Rise Time	t _R	_	1183	_		Vss = 20V, Vgs = 4.0V,	
Turn-Off Delay Time	t _{D(OFF)}	_	1810	_	ns	$I_S = 10A, R_g = 6.0\Omega$	
Turn-Off Fall Time	tF	_	1602	_		, , ,	

Notes:

- 5. Device mounted on FR-4 material with 1inch2 (6.45cm2), 2oz. (0.071mm thick) Cu.
- Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
- Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.





V_{SS}, SOURCE-SOURCE VOLTAGE (V) Figure 1. Typical Output Characteristic

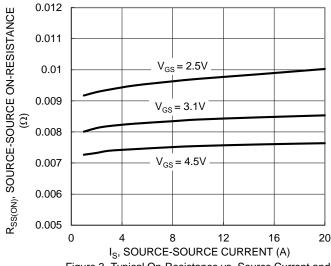


Figure 3. Typical On-Resistance vs. Source Current and Gate Voltage

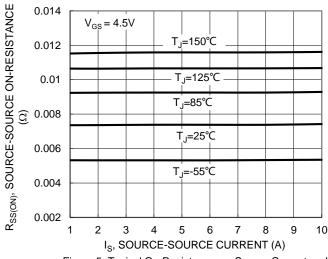
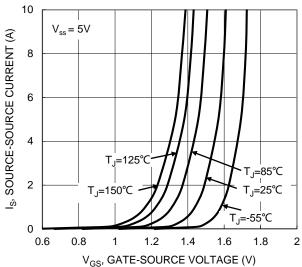
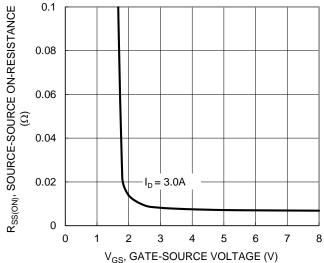


Figure 5. Typical On-Resistance vs. Source Current and Junction Temperature



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic



V_{GS}, GATE-SOURCE VOLTAGE (V)
Figure 4. Typical Transfer Characteristic

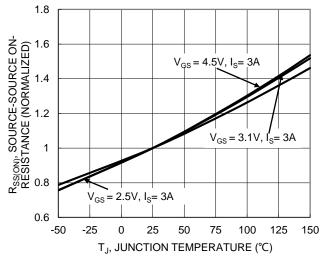


Figure 6. On-Resistance Variation with Junction Temperature



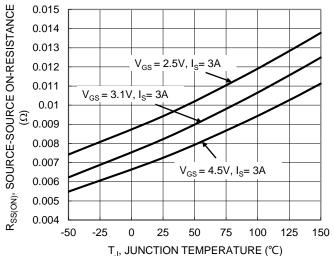


Figure 7. On-Resistance Variation with Junction Temperature

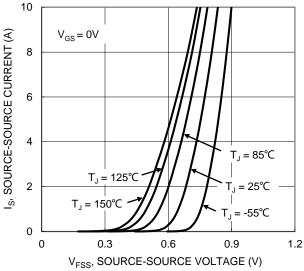


Figure 9. Diode Forward Voltage vs. Current

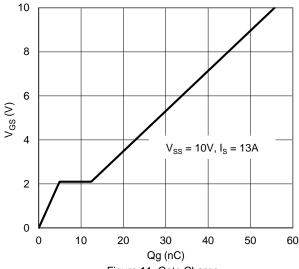


Figure 11. Gate Charge

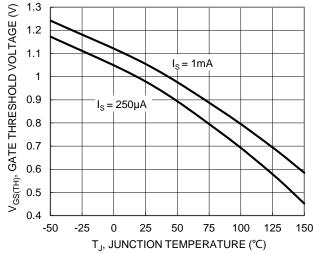
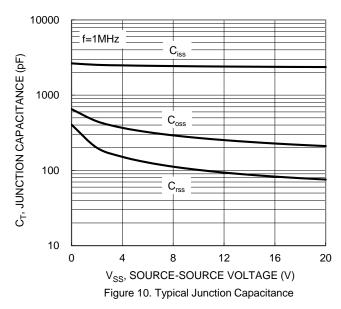


Figure 8. Gate Threshold Variation vs. Junction Temperature



 $\begin{array}{c} 100 \\ \hline \\ R_{SS(ON)} Limited \\ \hline \\ 10 \\ \hline \\ P_W = 100 \\$

Figure 12. SOA, Safe Operation Area



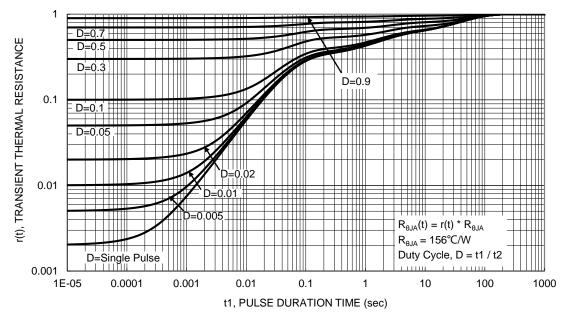


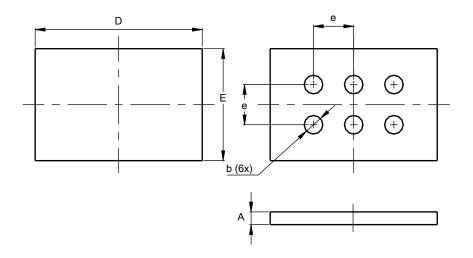
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X3-DSN2718-6

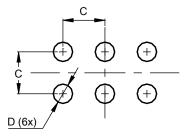


X3-DSN2718-6							
Dim	Min	Max	Тур				
Α	0.16	0.26	0.21				
b	0.27	0.33	0.30				
D	2.65	2.75	2.70				
E 1.76 1.86 1.81							
е	0.62	0.68	0.65				
All Dimensions in mm							

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X3-DSN2718-6



Di	Value
Dimensions	(in mm)
С	0.65
D	0.30



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DMN2012UCA6
Document number: DS39145 Rev. 3 - 2

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